HCT CO.,LTD.
74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi-do, 17383, Rep. of KOREA
TEL: +82-31-645-6300 FAX: +82-31-645-6401

FCC NFC REPORT

Certification

Applicant Name:
SAMSUNG Electronics Co., Ltd.

Address:
129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea

Date of Issue:
July 18, 2022

Test Site/Location:
74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi-do, 17383 KOREA

Report No.: HCT-RF-2207-FC019

FCC ID:	**A3LSMA233JPN**
APPLICANT:	**SAMSUNG Electronics Co., Ltd.**
Model:	SC-56C
Additional Model:	SCG18, SM-A233C
EUT Type:	Mobile Phone
RF Output Field Strength:	14.87 dBμV/m @30 m
Frequency of Operation:	13.56 MHz
Modulation type:	ASK
FCC Classification:	Low Power Communication Device Transmitter (DXX)
FCC Rule Part(s):	FCC Part 15.225 Subpart C

Engineering Statement:

The measurements shown in this report were made in accordance with the procedures indicated, and the emissions from this equipment were found to be within the limits applicable. I assume full responsibility for the accuracy and completeness of these measurements, and for the qualifications of all persons taking them. It is further stated that upon the basis of the measurements made, the equipment tested is capable of operation in accordance with the requirements of the FCC Rules under normal use and maintenance.

REVIEWED BY

Report prepared by : Woong Jin Kim
Engineer of Telecommunication Testing Center

Report approved by : Se Wook Park
Manager of Telecommunication Testing Center

This test results were applied only to the test methods required by the standard.

This laboratory is not accredited for the test results marked *.
The above Test Report is the accredited test result by (KS Q) ISO/IEC 17025 and KOLAS(Korea Laboratory Accreditation Scheme), which signed the ILAC-MRA. (HCT Accreditation No.: KT197)

Version

TEST REPORT NO.	DATE	DESCRIPTION
HCT-RF-2207-FC019	July 18, 2022	- First Approval Report

Table of Contents

1. EUT DESCRIPTION

Model	SC-56C
Additional Model	SCG18, SM-A233C
EUT Type	Mobile Phone
Power Supply	DC 4.20 V
Frequency of Operation	13.56 MHz
Transmit Power	14.87 dBμV/m @30 m
Modulation Type	ASK
Date(s) of Tests	June 23, 2022 ~ July 18, 2022
Serial number	Radiated : R3CT50MQF8M Conducted : R3CT50MQEKV

2. TEST METHODOLOGY

The measurement procedure described in the American National Standard of Procedures for Compliance Testing of Unlicensed Wireless Devices (ANSI C63.10-2013) is used in the measurement of the test device.

EUT CONFIGURATION

The EUT configuration for testing is installed on RF field strength measurement to meet the Commissions requirement and operating in a manner that intends to maximize its emission characteristics in a continuous normal application.

EUT EXERCISE

The EUT was operated in the engineering mode to fix the Tx frequency that was for the purpose of the measurements. According to its specifications, the EUT must comply with the requirements of the Section 15.207, 15.209 and 15.225 under the FCC Rules Part 15 Subpart C.

GENERAL TEST PROCEDURES

Conducted Emissions

The EUT is placed on the turntable, which is 0.8 m above ground plane. According to the requirements in Section 6.2 of ANSI C63.10. (Version :2013) Conducted emissions from the EUT measured in the frequency range between 0.15 MHz and 30MHz using CISPR Quasi-peak and average detector modes.

Radiated Emissions

The EUT is placed on a turn table, which is 0.8 m above ground plane. The turntable shall rotate 360 degrees to determine the position of maximum emission level. EUT is set 3 m away from the receiving antenna, which varied from 1 m to 4 m to find out the highest emission. And also, each emission was to be maximized by changing the polarization of receiving antenna both horizontal and vertical. In order to find out the max. emission, the relative positions of this hand-held transmitter (EUT) was rotated through three orthogonal axes according to the requirements in Section 6.6.5 of ANSI C63.10. (Version: 2013).

DESCRIPTION OF TEST MODES

The EUT has been tested under operating condition. Test program used to control the EUT for staying in continuous transmitting and receiving mode is programmed.

3. INSTRUMENT CALIBRATION

The measuring equipment, which was utilized in performing the tests documented herein, hasbeen calibrated in accordance with the manufacturer's recommendations for utilizing calibrationequipment, which is traceable to recognized national standards.

Especially, all antenna for measurement is calibrated in accordance with the requirements of C63.5 (Version : 2017).

4. FACILITIES AND ACCREDITATIONS

FACILITIES

The SAC(Semi-Anechoic Chamber) and conducted measurement facility used to collect the radiated data are located at the 74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi-do, 17383, Rep. of KOREA.

The site is constructed in conformance with the requirements of ANSI C63.4. (Version :2014) and CISPR Publication 22.

Detailed description of test facility was submitted to the Commission and accepted dated April 02, 2018 (Registration Number: KR0032).

EQUIPMENT

Radiated emissions are measured with one or more of the following types of Linearly polarized antennas: tuned dipole, bi-conical, log periodic, bi-log, and/or ridged waveguide, horn. Spectrum analyzers with pre-selectors and quasi-peak detectors are used to perform radiated measurements.

Conducted emissions are measured with Line Impedance Stabilization Networks and EMI Test Receivers. Calibrated wideband preamplifiers, coaxial cables, and coaxial attenuators are also used for making measurements.

All receiving equipment conforms to CISPR Publication 16-1, “Radio Interference Measuring Apparatus and Measurement Methods.”

5. ANTENNA REQUIREMENTS

According to FCC 47 CFR §15.203:

“An intentional radiator antenna shall be designed to ensure that no antenna other than that furnished by the responsible party can be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section.”

(1) The antennas of this E.U.T are permanently attached.

(2)The E.U.T Complies with the requirement of §15.203

6. MEASUREMENT UNCERTAINTY

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.10-2013.

All measurement uncertainty values are shown with a coverage factor of k = 2 to indicate a 95 % level of confidence.

The measurement data shown herein meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and, thus, can be compared directly to specified limits to determine compliance.

.

Parameter	Expanded Uncertainty (dB)
Conducted Disturbance (150 kHz ~ 30 MHz)	2.00 (Confidence level about 95 %, k=2)
Radiated Disturbance (9 kHz ~ 30 MHz)	4.40 (Confidence level about 95 %, k=2)
Radiated Disturbance (30 MHz ~ 1 GHz)	5.74 (Confidence level about 95 %, k=2)
Radiated Disturbance (1 GHz ~ 18 GHz)	5.51 (Confidence level about 95 %, k=2)
Radiated Disturbance (18 GHz ~ 40 GHz)	5.92 (Confidence level about 95 %, k=2)
Radiated Disturbance (Above 40 GHz)	5.48 (Confidence level about 95 %, k=2)

7. DESCRIPTION OF TESTS

7.1. RadiatedTest

Limit (Operation within the band 13.110 MHz – 14.010 MHz)

Frequency (MHz)	Field Strength (μV/m)	Measurement Distance (m)
13.553 – 13.567	15,848	30
13.410 ≤ f ≤ 13.553 13.567 ≤ f ≤ 13.710	334	30
13.110 ≤ f ≤ 13.410 13.710 ≤ f ≤ 14.010	106	30

Note:

1. 15,848 μV/m = 84.0dBμV/m
2. 334 μV/m = 50.47 dBμV/m
3. 106μV/m = 40.51dBμV/m

Limit(Radiated Spurious Emissions)

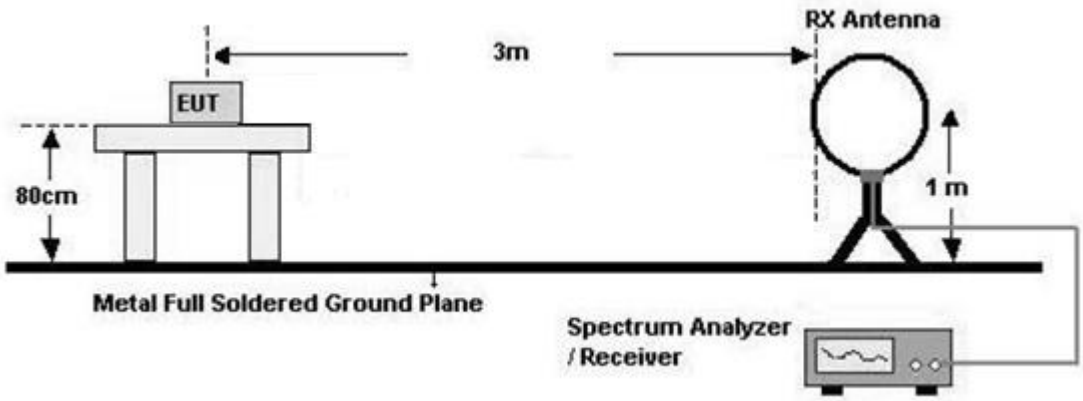
Frequency (MHz)	Field Strength (μV/m)	Measurement Distance (m)
0.009 – 0.490	2400/F(kHz)	300
0.490 – 1.705	24000/F(kHz)	30
1.705 – 30	30	30
30-88	※100	3
88-216	※150	3
216-960	※200	3
Above 960	500	3

※:

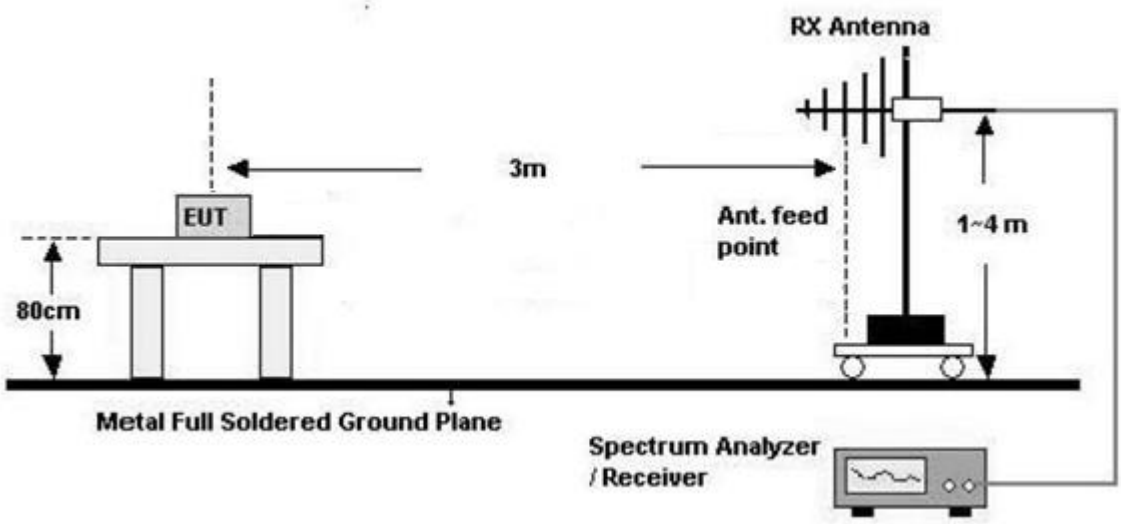
Exceptasprovidedin15.209(g), fundamental emissions from intentional radiators operating under this Section shall not be located in the frequency bands 54-72MHz, 76-88MHz,174-216MHz or 470-806MHz. However, operation within these frequency bands is permitted under other sections ofthisPart,e.g.15.231and 15.241.

Test Configuration

Below 30 MHz



30 MHz - 1 GHz



Test Procedure of in-band

1. The EUT was placed on a non-conductive table located on semi-anechoic chamber.
2. The loop antenna was placed at a location 3 m from the EUT
3. The EUT is placed on a turntable, which is 0.8m above ground plane.
4. We have done x, y, z planes in EUT and horizontal and vertical polarization and Parallel to the ground plane in detecting antenna.
5. The turntable shall be rotated for 360 degrees to determine the position of maximum emission level.
6. Distance Correction Factor =40log(3 m/30 m)= - 40 dB
   Measurement Distance : 3 m(Below30 MHz)
7. Spectrum Setting

- Detector = Peak
- Trace = Max Hold
- RBW = 9 kHz
- VBW ≥ 3 x RBW

8.Total = Measured Value + Antenna Factor(A.F) + Cable Loss(C.L) + Distance Factor(D.F)

Test Procedure of Radiated spurious emissions (Below 30 MHz)

1. The EUT was placed on a non-conductive table located on semi-anechoic chamber.
2. The loop antenna was placed at a location 3 m from the EUT
3. The EUT is placed on a turntable, which is 0.8m above ground plane.
4. We have done x, y, z planes in EUT and horizontal and vertical polarization and Parallel to the ground plane in detecting antenna.
5. The turntable shall be rotated for 360 degrees to determine the position of maximum emission level.
6. Distance Correction Factor(0.009 MHz – 0.490 MHz) =40log(3 m/300 m)= - 80 dB
   Measurement Distance : 3 m
7. Distance Correction Factor(0.490 MHz – 30 MHz) =40log(3 m/30 m)= - 40 dB
   Measurement Distance : 3 m
8. Spectrum Setting
   - Frequency Range = 9 kHz ~ 30 MHz
   - Detector = Peak
   - Trace = Maxhold
   - RBW = 9 kHz
   - VBW ≥ 3 x RBW

9.Total = Measured Value + Antenna Factor(A.F) + Cable Loss(C.L) + Distance Factor(D.F)

10. Measurement value only up to 6 maximum emissions noted, or would be lesser if no specific emissions from the EUT are recorded (ie: margin > 20 dB from the applicable limit) and considered that's already beyond the background noise floor.

KDB 414788 OFS and Chamber Correlation Justification

Base on FCC 15.31 (f) (2): measurements may be performed at a distance closer than that specified in the regulations; however, an attempt should be made to avoid making measurements in the near field.

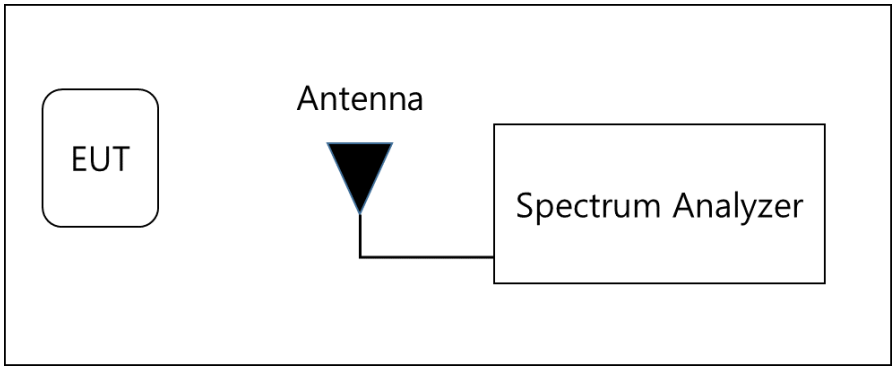
OFS and chamber correlation testing had been performed and chamber measured test result is the worst case test result.

Test Procedure of Radiated spurious emissions (Above 30 MHz)

1. The EUT was placed on a non-conductive table located on semi-anechoic chamber.
2. The EUT is placed on a turntable, which is 0.8m above ground plane.
3. The Hybrid antenna was placed at a location 3 m from the EUT, which is varied from 1m to 4m to find out the highest emissions.
4. We have done x, y, z planes in EUT and horizontal and vertical polarization in detecting antenna.
5. The turntable shall be rotated for 360 degrees to determine the position of maximum emission level.
6. Spectrum Setting
   - Frequency Range = 30 MHz ~ 1 GHz
   - Detector = Peak
   - Trace = Max-hold
   - RBW = 100 kHz
   - VBW ≥ 3 x RBW
7. Total = Measured Value + Antenna Factor(A.F) + Cable Loss(C.L)
8. Measurement value only up to 6 maximum emissions noted, or would be lesser if no specific emissions from the EUT are recorded (ie: margin > 20 dB from the applicable limit) and considered that's already beyond the background noise floor.

7.2. 20 dB Bandwidth

Test Configuration



Test Procedure

The 20 dB bandwidth was measured by using a spectrum analyzer.

(Procedure 6.9.2 in ANSI 63.10-2013)

1) RBW = 1 % ~ 5 % of the OBW
2) VBW = approximately three times RBW
3) Span =between two times and five times the OBW
4) Detector = Peak
5) Trace mode = Max hold
6) Allow the trace to stabilize

Note :

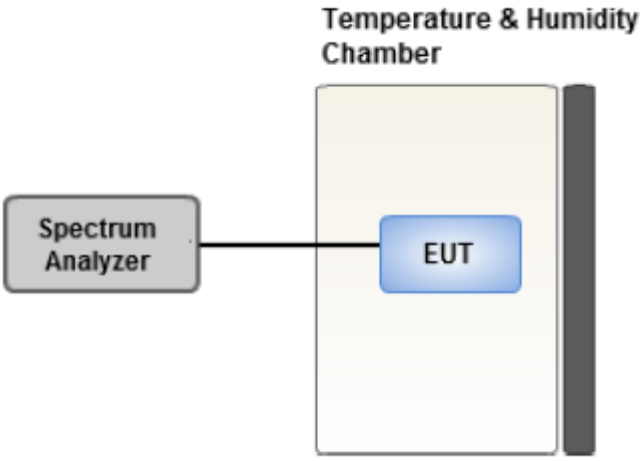
We tested Occupied Bandwidth using the automatic bandwidth measurement capability of a spectrum analyzer.

7.3. Frequency Stability

Limit

The frequency tolerance of the carrier signal shall be maintained within ± 0.01 % of the operating frequency.

Test Configuration



Test Procedure.

For battery operated equipment, the equipment tests shall be performed using a new battery.

1) Turn the EUT OFF and place it inside the environmental temperature chamber. For devices that have oscillator heaters, energize only the heater circuit.
2) Set the temperature control on the chamber to the highest specified in the regulatory requirements for the type of device and allow the oscillator heater and the chamber temperature to stabilize.
3) While maintaining a constant temperature inside the environmental chamber, turn the EUT ON and record the operating frequency at startup, and at 2 minutes, 5 minutes, and 10 minutes after the EUT is energized. Four measurements in total are made.
4) The frequency tolerance of the carrier signal shall be maintained within +/- 0.01% of the operating frequency.

Note:

1) Temperature:
   The temperature is varied from -20 °C to + 50 °C using an environmental chamber.
2) Primary Supply Voltage :
   The primary supply voltage is varied from 85 % to 115 % of the nominal value for non hand-carried battery and AC powered equipment.
   For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

7.4. AC Power line Conducted Emissions

Limit

For an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies, within the band 150 kHz to 30 MHz, shall not exceed the limits in the following table, as measured using a 50 μH/50 ohms line impedance stabilization network (LISN).

Frequency Range (MHz)	Limits (dBμV)	
	Quasi-peak	Average
0.15 to 0.50	66 to 56[a]	56 to 46[a]
0.50 to 5	56	46
5 to 30	60	50

[a]Decreases with the logarithm of the frequency.

Compliance with this provision shall be based on the measurement of the radio frequency voltage between each power line (LINE and NEUTRAL) and ground at the power terminals.

Test Configuration

See test photographs attached in Annex A for the actual connections between EUT and support equipment.

Test Procedure

1. The EUT is placed on a wooden table 80 cm above the reference ground plane.
2. The EUT is connected via LISN to a test power supply.
3. The measurement results are obtained as described below:
4. Detectors : Quasi Peak and Average Detector.
5. The EUT is the device operating below 30 MHz.
   - For unterminated the Antenna, the AC line conducted tests are performed with the antenna connected
   - For terminated the Antenna, the AC line conducted tests are performed with a dummy load connected to the EUT antenna output terminal.

Sample Calculation

Quasi-peak (Final Result) = Measured Value + Correction Factor

7.5. Worst case configuration and mode

Radiated test

1. All modes of operation were investigated and the worst case configuration results are reported.
   - Mode : Stand alone, Stand alone + external accessories(Earphone, etc)
   - Worst case : Stand alone
2. EUT Axis : Z
3. All type and bitrate were investigated and the worst case results are reported.
   - Worst case : Type A, 106 kbps
4. All mode of without tag and with tag were investigated and the worst case configuration results are reported.
   - Worst case : Without Tag
5. All position of loop antenna were investigated and the worst case configuration results are reported.
   - Position : Horizontal, Vertical, Parallel to the ground plane
   - Worst case : Horizontal
6. SC-56C, SCG18, SM-A233C were tested and the worst case results are reported.
   (Worst case : SC-56C)

AC Power line Conducted Emissions

1. All modes of operation were investigated and the worst case configuration results are reported.
   - Mode : Stand alone + Earphone + Travel Adapter, Stand alone + Travel Adapter
   - Worst case : Stand alone + Travel Adapter
2. All modes(For unterminated the Antenna, terminated the Antenna) of operation were investigated and the worst case configuration results are reported.
   - Worst case : Unterminated the Antenna
3. SC-56C, SCG18, SM-A233C were tested and the worst case results are reported.
   (Worst case : SC-56C)

20 dB Bandwidth & Frequency Stability

1. All type and bitrate were investigated and the worst case results are reported.
   - Worst case : Type A, 106 kbps
2. SC-56C, SCG18, SM-A233C were tested and the worst case results are reported.
   (Worst case : SC-56C)

8. TEST SUMMARY

Regulation	Requirement	Result
Part 15.225 (a)	Radiated Electric Field Emissions (13.553 MHz to 13.567 MHz)	Pass
Part 15.225 (b)	Radiated Electric Field Emissions (13.410 ≤ f ≤ 13.553, 13.567 ≤ f ≤ 13.710)	Pass
Part 15.225 (c)	Radiated Electric Field Emissions (13.110 ≤ f ≤ 13.410, 13.710 ≤ f ≤ 14.010)	Pass
Part 15.209	Radiated Electric Field Emissions (9 kHz to 30 MHz)	Pass
Part 15.209	Radiated Electric Field Emissions (30 MHz to 1 GHz)	Pass
Part 15.225 (e)	Frequency Stability	Pass
Part 15.207	AC power conducted emissions (150 kHz to 30 MHz)	Pass
Part 15.215 (c)	20 dB Bandwidth	Pass

9. TEST RESULT

9.1. Operation within the band 13.110 MHz – 14.010 MHz

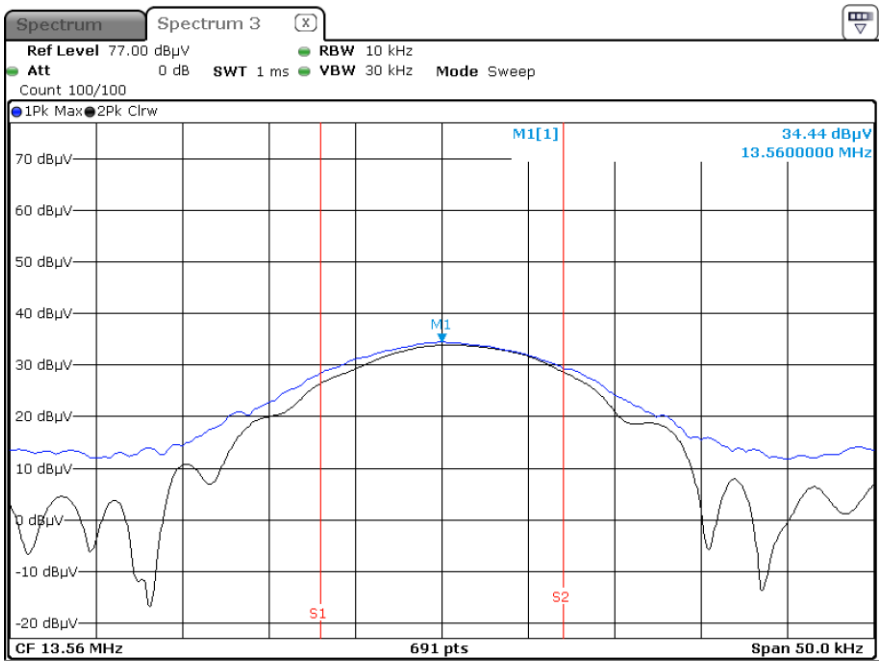
Measured Frequency Range : 13.553 MHz-13.567 MHz							
Frequency (MHz)	Measured Value (dBµV/m) @3 m	Ant. Factor +Cable Loss (dB/m)	Distance Correction (dB)	Ant. POL (H/V)	Total (dBµV/m) @30 m	Limit (dBµV/m) @30 m	Margin (dB)
13.5600	34.44	20.43	-40.00	H	14.87	84.00	69.13
13.5596	29.42	20.43	-40.00	V	9.85	84.00	74.15

Measured Frequency Range : 13.410 MHz-13.553 MHz and 13.567 MHz-13.710 MHz							
Frequency (MHz)	Measured Value (dBµV/m) @3 m	Ant. Factor + Cable Loss (dB/m)	Distance Correction (dB)	Ant. POL (H/V)	Total (dBµV/m) @30 m	Limit (dBµV/m) @30 m	Margin (dB)
13.5529	28.33	20.43	-40.00	H	8.76	50.47	41.71
13.5671	29.29	20.43	-40.00	H	9.72	50.47	40.75

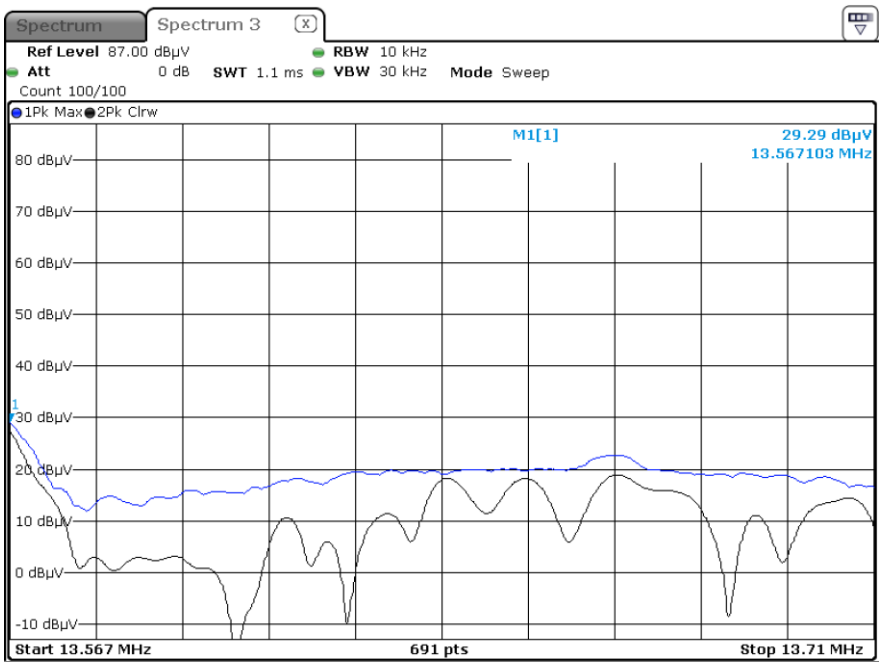
Measured Frequency Range : 13.110 MHz – 13.410 MHz and 13.710 MHz-14.010 MHz							
Frequency (MHz)	Measured Value (dBµV/m) @3 m	Ant. Factor + Cable Loss (dB/m)	Distance Correction (dB)	Ant. POL (H/V)	Total (dBµV/m) @30 m	Limit (dBµV/m) @30 m	Margin (dB)
13.3486	20.64	20.43	-40.00	H	1.07	40.51	39.44
13.7723	19.80	20.43	-40.00	H	0.23	40.51	40.28

▣ Test Plot

13.553 MHz ~ 13.567 MHz (Z-H)



13.567 MHz - 13.710 MHz (Z-H)



Note:

Plot of worst case are only reported.

9.2. Radiated Emission 9 kHz – 30 MHz

Measured Frequency Range : 9 kHz - 30 MHz							
Frequency (MHz)	**Measured Value (dBµV/m) @3 m**	**Ant. Factor + Cable Loss (dB/m)**	**Distance Correction (dB)**	**Ant. POL (H/V)**	**Total (dBµV/m) @30 m**	**Limit (dBµV/m) @30 m**	**Margin (dB)**
12.968	10.33	20.43	-40.00	H	-9.24	29.54	38.78
19.807	11.30	20.83	-40.00	H	-7.87	29.54	37.41
27.1301	9.78	20.58	-40.00	H	-9.64	29.54	39.18
27.4196	9.09	20.58	-40.00	V	-10.33	29.54	39.87

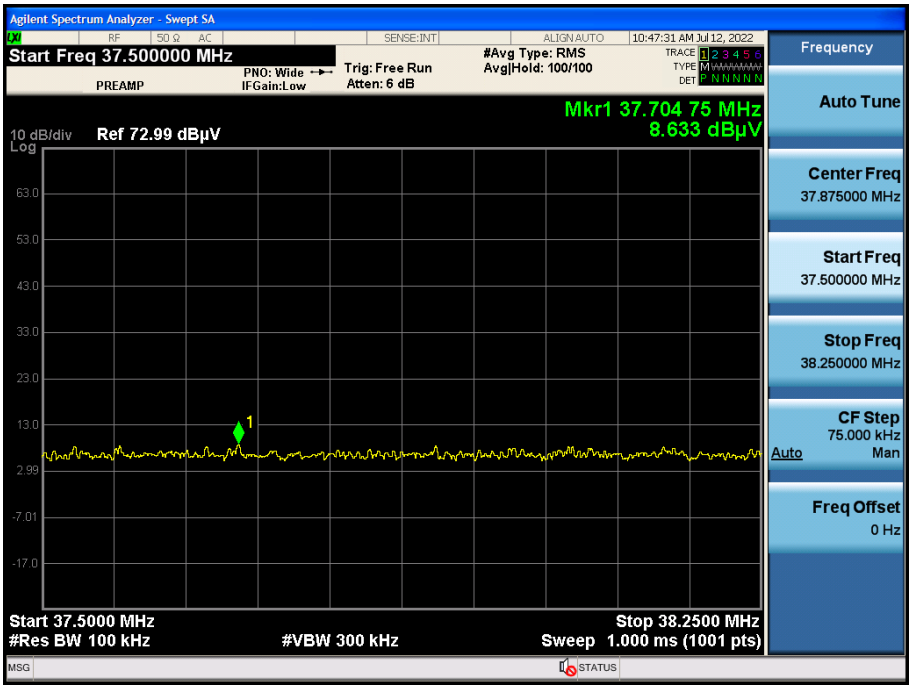
9.3. Radiated Emission 30 MHz – 1000 MHz

Measured Frequency Range : 30 MHz - 1000 MHz							
Frequency (MHz)	Measured Value (dBµV/m) @3 m	Ant. Factor (dB/m)	Cable Loss (dB)	Ant. Pol (H/V)	Total (dBµV/m)	Limit (dBµV/m)	Margin (dB)
# 37.704	8.633	19.50	0.49	H	28.623	40.00	11.377
38.250	8.486	19.50	0.56	H	28.546	40.00	11.454
103.608	9.216	15.79	0.78	V	25.786	43.50	17.714
#115.026	9.545	17.09	0.86	H	27.495	43.50	16.005
#130.305	7.610	18.50	0.91	H	27.02	43.50	16.480
148.537	8.103	20.19	0.98	V	29.273	43.50	14.227

Note:

1. # is the result for restricted band.

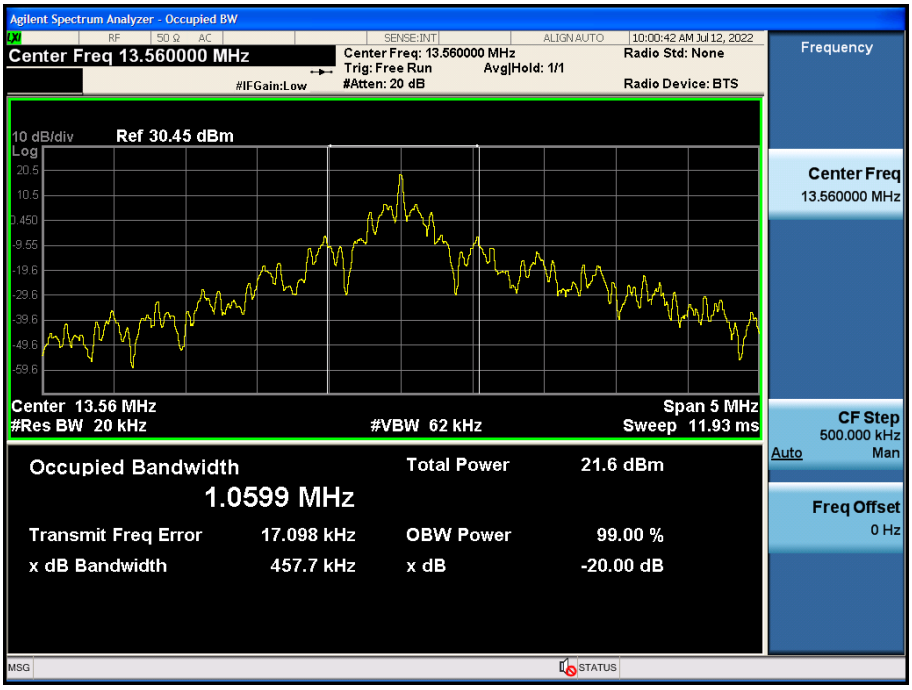
▣ Test Plot



Note:

Plot of worst case are only reported

9.4. 20 dB Bandwidth



9.5. Frequency Stability

Startup

PERATING FREQUENCY: 13.56 MHz

REFERENCE VOLTAGE: 4.20 VDC

DEVIATION LIMIT: ±0.01 % =±1356 Hz

Voltage (%)	Power (VDC)	Temp. (℃)	Frequency (MHz)	Frequency Dev. (Hz)	Frequency Dev (%)
100%	4.20	-20	13.560071	71	0.0005270
100%		-10	13.560065	65	0.0004785
100%		0	13.560062	62	0.0004540
100%		+10	13.560058	58	0.0004259
100%		+20(Ref.)	13.560056	56	0.0004120
100%		+30	13.560060	60	0.0004400
100%		+40	13.560068	68	0.0005027
100%		+50	13.560073	73	0.0005378
LOW	3.80	+20	13.560074	74	0.0005466
HIGH	4.40	+20	13.560069	69	0.0005091

2 minutes

PERATING FREQUENCY: 13.56 MHz

REFERENCE VOLTAGE: 4.20 VDC

DEVIATION LIMIT: ±0.01 % =±1356 Hz

Voltage (%)	Power (VDC)	Temp. (℃)	Frequency (MHz)	Frequency Dev. (Hz)	Frequency Dev (%)
100%	4.20	-20	13.560074	74	0.0005472
100%		-10	13.560069	69	0.0005062
100%		0	13.560064	64	0.0004698
100%		+10	13.560060	60	0.0004403
100%		+20(Ref.)	13.560058	58	0.0004295
100%		+30	13.560061	61	0.0004471
100%		+40	13.560069	69	0.0005081
100%		+50	13.560075	75	0.0005529
LOW	3.80	+20	13.560075	75	0.0005543
HIGH	4.40	+20	13.560073	73	0.0005360

5 minutes

PERATING FREQUENCY: 13.56 MHz

REFERENCE VOLTAGE: 4.20 VDC

DEVIATION LIMIT: ±0.01 % =±1356 Hz

Voltage (%)	Power (VDC)	Temp. (℃)	Frequency (MHz)	Frequency Dev. (Hz)	Frequency Dev (%)
100%	4.20	-20	13.560081	81	0.0005962
100%		-10	13.560075	75	0.0005549
100%		0	13.560072	72	0.0005301
100%		+10	13.560068	68	0.0005040
100%		+20(Ref.)	13.560063	63	0.0004645
100%		+30	13.560067	67	0.0004928
100%		+40	13.560076	76	0.0005584
100%		+50	13.560081	81	0.0005996
LOW	3.80	+20	13.560080	80	0.0005929
HIGH	4.40	+20	13.560078	78	0.0005788

10 minutes

PERATING FREQUENCY: 13.56 MHz

REFERENCE VOLTAGE: 4.20 VDC

DEVIATION LIMIT: ±0.01 % =±1356 Hz

Voltage (%)	Power (VDC)	Temp. (℃)	Frequency (MHz)	Frequency Dev. (Hz)	Frequency Dev (%)
100%	4.20	-20	13.560074	74	0.0005432
100%		-10	13.560067	67	0.0004954
100%		0	13.560063	63	0.0004671
100%		+10	13.560060	60	0.0004456
100%		+20(Ref.)	13.560057	57	0.0004226
100%		+30	13.560061	61	0.0004462
100%		+40	13.560070	70	0.0005139
100%		+50	13.560074	74	0.0005458
LOW	3.80	+20	13.560076	76	0.0005603
HIGH	4.40	+20	13.560072	72	0.0005325

9.6. POWERLINE CONDUCTED EMISSIONS

Conducted Emissions (Line 1)

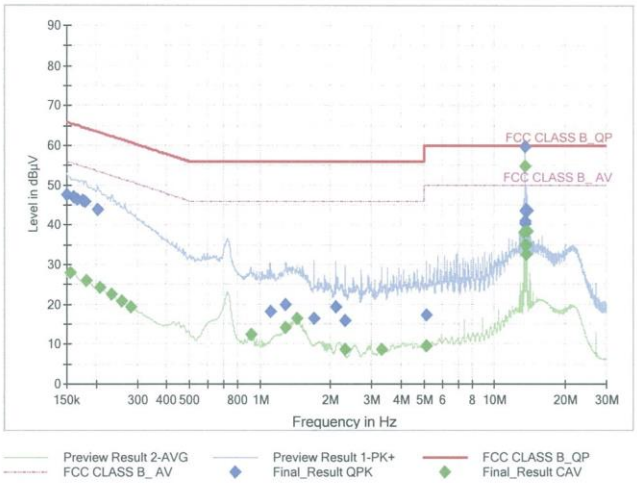
NFC MODE_L1 1 / 2

Test Report

Common Information

EUT :	SC-56C
Manufacturer :	SAMSUNG
Test Site:	SHIELD ROOM
Operating Conditions :	NFC MODE_L1

Full Spectrum



Final_Result_QPK

Frequency (MHz)	QuasiPeak (dBµV)	Limit (dBµV)	Margin (dB)	Bandwidth (kHz)	Line	Filter	Corr. (dB)
0.1500	47.51	66.00	18.49	9.000	L1	OFF	9.6
0.1613	47.08	65.40	18.32	9.000	L1	OFF	9.6
0.1658	46.48	65.17	18.69	9.000	L1	OFF	9.6
0.1748	46.13	64.73	18.60	9.000	L1	OFF	9.6
0.1793	45.79	64.52	18.73	9.000	L1	OFF	9.6
0.2040	43.75	63.45	19.69	9.000	L1	OFF	9.6
1.1053	18.17	56.00	37.83	9.000	L1	OFF	9.7
1.2920	19.85	56.00	36.15	9.000	L1	OFF	9.7
1.7060	16.40	56.00	39.60	9.000	L1	OFF	9.7
2.1155	19.35	56.00	36.65	9.000	L1	OFF	9.7
2.3045	15.73	56.00	40.27	9.000	L1	OFF	9.8
5.1125	17.20	60.00	42.80	9.000	L1	OFF	9.9
13.4555	43.64	60.00	16.36	9.000	L1	OFF	10.2
13.4623	41.00	60.00	19.00	9.000	L1	OFF	10.2
13.4780	40.33	60.00	19.67	9.000	L1	OFF	10.2
13.5613	59.71	60.00	0.29	9.000	L1	OFF	10.2
13.6670	43.70	60.00	16.30	9.000	L1	OFF	10.2
13.7728	43.64	60.00	16.36	9.000	L1	OFF	10.2

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NFC MODE_L1 2 / 2

Final_Result_CAV

Frequency (MHz)	CAverage (dBµV)	Limit (dBµV)	Margin (dB)	Bandwidth (kHz)	Line	Filter	Corr. (dB)
0.1545	27.90	55.75	27.85	9.000	L1	OFF	9.6
0.1815	25.91	54.42	28.50	9.000	L1	OFF	9.6
0.2085	24.14	53.27	29.13	9.000	L1	OFF	9.6
0.2333	22.46	52.33	29.88	9.000	L1	OFF	9.6
0.2580	20.90	51.50	30.60	9.000	L1	OFF	9.6
0.2805	19.21	50.80	31.59	9.000	L1	OFF	9.6
0.9163	12.28	46.00	33.72	9.000	L1	OFF	9.7
1.2898	14.14	46.00	31.86	9.000	L1	OFF	9.7
1.4338	16.35	46.00	29.65	9.000	L1	OFF	9.7
2.3023	8.68	46.00	37.32	9.000	L1	OFF	9.8
3.3148	8.62	46.00	37.38	9.000	L1	OFF	9.8
5.1125	9.47	50.00	40.53	9.000	L1	OFF	9.9
13.3498	38.02	50.00	11.98	9.000	L1	OFF	10.2
13.4555	34.83	50.00	15.17	9.000	L1	OFF	10.2
13.5613	54.95	50.00	-4.95	9.000	L1	OFF	10.2
13.6535	32.52	50.00	17.48	9.000	L1	OFF	10.2
13.6670	34.81	50.00	15.19	9.000	L1	OFF	10.2
13.7728	38.50	50.00	11.50	9.000	L1	OFF	10.2

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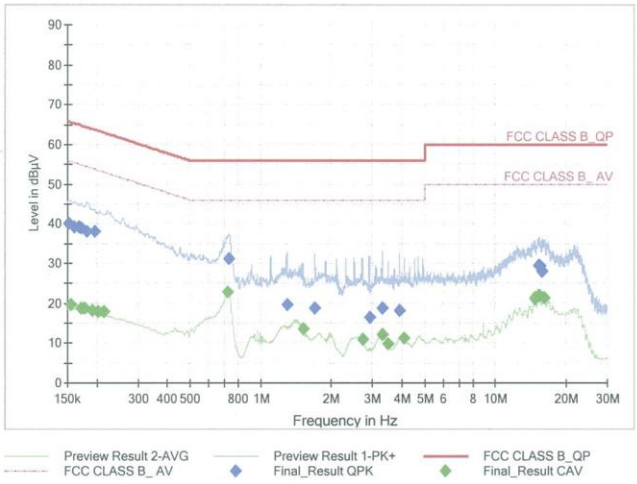
Test Report

Common Information

EUT :	SC-56C
Manufacturer :	SAMSUNG
Test Site:	SHIELD ROOM
Operating Conditions :	NFC TERM MODE_L1

Full Spectrum



Final_Result_QPK

Frequency (MHz)	QuasiPeak (dBµV)	Limit (dBµV)	Margin (dB)	Bandwidth (kHz)	Line	Filter	Corr. (dB)
0.1523	40.03	65.88	25.84	9.000	L1	OFF	9.6
0.1613	39.18	65.40	26.22	9.000	L1	OFF	9.6
0.1680	39.29	65.06	25.77	9.000	L1	OFF	9.6
0.1725	38.98	64.84	25.86	9.000	L1	OFF	9.6
0.1815	38.18	64.42	26.24	9.000	L1	OFF	9.6
0.1973	38.19	63.73	25.54	9.000	L1	OFF	9.6
0.7363	31.03	56.00	24.97	9.000	L1	OFF	9.7
1.2943	19.66	56.00	36.34	9.000	L1	OFF	9.7
1.7060	18.79	56.00	37.21	9.000	L1	OFF	9.7
2.9075	16.34	56.00	39.66	9.000	L1	OFF	9.8
3.3193	18.88	56.00	37.12	9.000	L1	OFF	9.8
3.9200	18.15	56.00	37.85	9.000	L1	OFF	9.8
15.2825	29.39	60.00	30.61	9.000	L1	OFF	10.2
15.3568	29.43	60.00	30.57	9.000	L1	OFF	10.2
15.3905	29.54	60.00	30.46	9.000	L1	OFF	10.2
15.4153	29.36	60.00	30.64	9.000	L1	OFF	10.2
15.4513	29.19	60.00	30.81	9.000	L1	OFF	10.2
15.8180	27.96	60.00	32.04	9.000	L1	OFF	10.2

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NFC TERM MODE_L1 2 / 2

Final_Result_CAV

Frequency (MHz)	CAverage (dBµV)	Limit (dBµV)	Margin (dB)	Bandwidth (kHz)	Line	Filter	Corr. (dB)
0.1545	19.66	55.75	36.09	9.000	L1	OFF	9.6
0.1725	18.74	54.84	36.10	9.000	L1	OFF	9.6
0.1770	18.72	54.63	35.90	9.000	L1	OFF	9.6
0.1928	18.11	53.92	35.81	9.000	L1	OFF	9.6
0.2040	17.98	53.45	35.47	9.000	L1	OFF	9.6
0.2153	17.90	53.00	35.10	9.000	L1	OFF	9.6
0.7250	22.85	46.00	23.15	9.000	L1	OFF	9.7
1.5170	13.44	46.00	32.56	9.000	L1	OFF	9.7
2.7185	10.83	46.00	35.17	9.000	L1	OFF	9.8
3.3193	12.02	46.00	33.98	9.000	L1	OFF	9.8
3.5105	9.90	46.00	36.10	9.000	L1	OFF	9.8
4.1090	11.36	46.00	34.64	9.000	L1	OFF	9.8
14.7133	21.36	50.00	28.64	9.000	L1	OFF	10.2
14.7313	21.12	50.00	28.88	9.000	L1	OFF	10.2
14.7628	21.11	50.00	28.89	9.000	L1	OFF	10.2
15.3568	22.03	50.00	27.97	9.000	L1	OFF	10.2
15.4490	21.93	50.00	28.07	9.000	L1	OFF	10.2
16.2298	21.45	50.00	28.55	9.000	L1	OFF	10.3

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Conducted Emissions (Line 2)

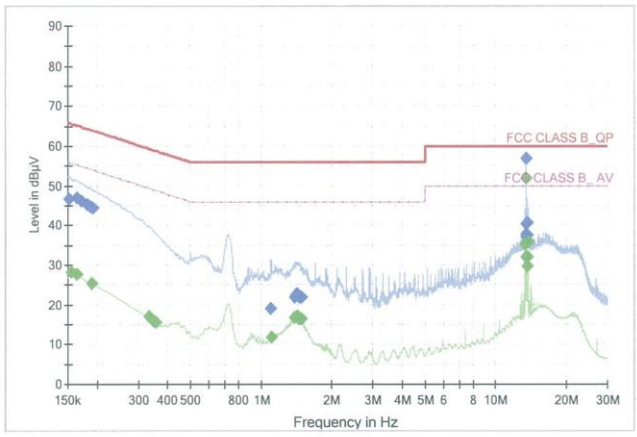
NFC MODE_N 1 / 2

Test Report

Common Information

EUT :	SC-56C
Manufacturer :	SAMSUNG
Test Site:	SHIELD ROOM
Operating Conditions :	NFC MODE_N

Full Spectrum



Final_Result_QPK

Frequency (MHz)	QuasiPeak (dBµV)	Limit (dBµV)	Margin (dB)	Bandwidth (kHz)	Line	Filter	Corr. (dB)
0.1523	46.84	65.88	19.04	9.000	N	OFF	9.6
0.1635	47.16	65.28	18.13	9.000	N	OFF	9.6
0.1725	46.10	64.84	18.74	9.000	N	OFF	9.6
0.1815	45.29	64.42	19.12	9.000	N	OFF	9.6
0.1883	44.77	64.11	19.35	9.000	N	OFF	9.6
0.1928	44.42	63.92	19.50	9.000	N	OFF	9.6
1.1030	19.01	56.00	36.99	9.000	N	OFF	9.7
1.3843	22.03	56.00	33.97	9.000	N	OFF	9.7
1.4135	22.52	56.00	33.48	9.000	N	OFF	9.7
1.4248	22.75	56.00	33.25	9.000	N	OFF	9.7
1.4630	21.81	56.00	34.19	9.000	N	OFF	9.7
1.4923	21.96	56.00	34.04	9.000	N	OFF	9.7
13.4555	40.38	60.00	19.62	9.000	N	OFF	10.2
13.4623	37.80	60.00	22.20	9.000	N	OFF	10.2
13.4780	37.24	60.00	22.76	9.000	N	OFF	10.2
13.5613	56.82	60.00	3.18	9.000	N	OFF	10.2
13.6513	37.46	60.00	22.54	9.000	N	OFF	10.2
13.6670	40.57	60.00	19.43	9.000	N	OFF	10.2

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NFC MODE_N 2 / 2

Final_Result_CAV

Frequency (MHz)	CAverage (dBµV)	Limit (dBµV)	Margin (dB)	Bandwidth (kHz)	Line	Filter	Corr. (dB)
0.1545	28.24	55.75	27.52	9.000	N	OFF	9.6
0.1635	27.68	55.28	27.61	9.000	N	OFF	9.6
0.1905	25.49	54.02	28.53	9.000	N	OFF	9.6
0.3345	16.95	49.34	32.39	9.000	N	OFF	9.6
0.3480	15.79	49.01	33.22	9.000	N	OFF	9.6
0.3570	15.59	48.80	33.21	9.000	N	OFF	9.6
1.1075	11.82	46.00	34.18	9.000	N	OFF	9.7
1.3865	16.82	46.00	29.18	9.000	N	OFF	9.7
1.4225	17.04	46.00	28.96	9.000	N	OFF	9.7
1.4338	17.10	46.00	28.90	9.000	N	OFF	9.7
1.4585	16.59	46.00	29.41	9.000	N	OFF	9.7
1.4900	16.58	46.00	29.42	9.000	N	OFF	9.7
13.3498	35.10	50.00	14.90	9.000	N	OFF	10.2
13.4555	31.99	50.00	18.01	9.000	N	OFF	10.2
13.5613	52.04	50.00	-2.04	9.000	N	OFF	10.2
13.6558	29.72	50.00	20.28	9.000	N	OFF	10.2
13.6670	31.98	50.00	18.02	9.000	N	OFF	10.2
13.7728	35.64	50.00	14.36	9.000	N	OFF	10.2

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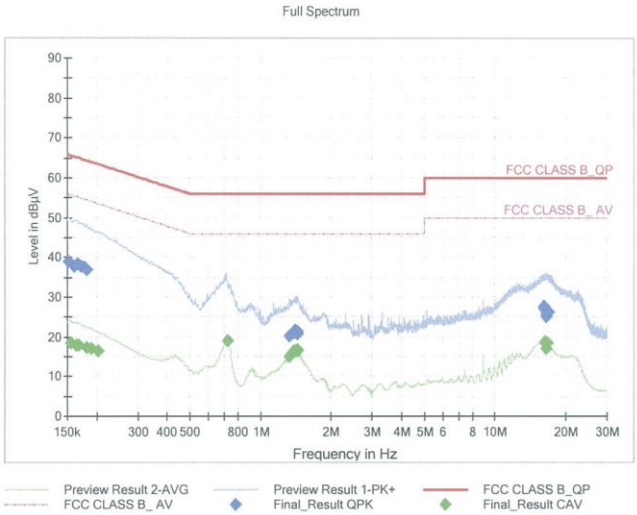
Test Report

Common Information

EUT :	SC-56C
Manufacturer :	SAMSUNG
Test Site:	SHIELD ROOM
Operating Conditions :	NFC TERM MODE_N



Final_Result_QPK

Frequency (MHz)	QuasiPeak (dBµV)	Limit (dBµV)	Margin (dB)	Bandwidth (kHz)	Line	Filter	Corr. (dB)
0.1523	38.84	65.88	27.04	9.000	N	OFF	9.6
0.1613	37.85	65.40	27.55	9.000	N	OFF	9.6
0.1658	38.27	65.17	26.90	9.000	N	OFF	9.6
0.1725	37.66	64.84	27.18	9.000	N	OFF	9.6
0.1770	37.60	64.63	27.03	9.000	N	OFF	9.6
0.1815	37.00	64.42	27.42	9.000	N	OFF	9.6
1.3370	20.27	56.00	35.73	9.000	N	OFF	9.7
1.3843	21.02	56.00	34.98	9.000	N	OFF	9.7
1.4090	21.73	56.00	34.27	9.000	N	OFF	9.7
1.4203	21.42	56.00	34.58	9.000	N	OFF	9.7
1.4315	21.41	56.00	34.59	9.000	N	OFF	9.7
1.4405	20.88	56.00	35.12	9.000	N	OFF	9.7
16.1623	27.19	60.00	32.81	9.000	N	OFF	10.3
16.1668	27.77	60.00	32.23	9.000	N	OFF	10.3
16.1870	27.43	60.00	32.57	9.000	N	OFF	10.3
16.5605	25.15	60.00	34.85	9.000	N	OFF	10.3
16.5898	25.57	60.00	34.43	9.000	N	OFF	10.3
16.9903	26.16	60.00	33.84	9.000	N	OFF	10.3

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NFC TERM MODE_N 2 / 2

Final_Result_CAV

Frequency (MHz)	CAverage (dBµV)	Limit (dBµV)	Margin (dB)	Bandwidth (kHz)	Line	Filter	Corr. (dB)
0.1545	18.54	55.75	37.22	9.000	N	OFF	9.6
0.1635	17.83	55.28	37.46	9.000	N	OFF	9.6
0.1680	17.94	55.06	37.12	9.000	N	OFF	9.6
0.1815	17.25	54.42	37.17	9.000	N	OFF	9.6
0.1905	17.09	54.02	36.93	9.000	N	OFF	9.6
0.2040	16.44	53.45	37.01	9.000	N	OFF	9.6
0.7228	19.03	46.00	26.97	9.000	N	OFF	9.7
1.3280	14.89	46.00	31.12	9.000	N	OFF	9.7
1.3865	16.19	46.00	29.81	9.000	N	OFF	9.7
1.3978	16.50	46.00	29.50	9.000	N	OFF	9.7
1.4090	16.50	46.00	29.50	9.000	N	OFF	9.7
1.4338	16.60	46.00	29.40	9.000	N	OFF	9.7
1.4450	16.41	46.00	29.59	9.000	N	OFF	9.7
16.2568	18.84	50.00	31.16	9.000	N	OFF	10.3
16.3580	18.51	50.00	31.49	9.000	N	OFF	10.3
16.6010	16.96	50.00	33.04	9.000	N	OFF	10.3
16.7945	18.34	50.00	31.66	9.000	N	OFF	10.3
16.8058	18.40	50.00	31.60	9.000	N	OFF	10.3

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10. LIST OF TEST EQUIPMENT

Conducted Test

Equipment	Model	Manufacturer	Serial No.	Due to Calibration	Calibration Interval
LISN	ENV216	Rohde & Schwarz	102245	08/23/2022	Annual
EMI Test Receiver	ESR	Rohde & Schwarz	101910	06/07/2023	Annual
Temperature Chamber	SU-642	ESPEC	0093008124	03/04/2023	Annual
Signal Analyzer	N9030A	Agilent	MY49431210	01/11/2023	Annual
DC Power Supply	E3646A	Agilent	MY40002937	12/14/2022	Annual
Attenuator(10 dB)	8493C	Hewlett Packard	07560	06/14/2023	Annual
Software	EMC32	Rohde & Schwarz	N/A	N/A	N/A

Note:

1. Equipment listed above that calibrated during the testing period was set for test after the calibration.

2. Equipment listed above that has a calibration due date during the testing period, the testing is completed before equipment expiration date.

Radiated Test

Equipment	Model	Manufacturer	Serial No.	Due to Calibration	Calibration Interval
Controller(Antenna mast)	CO3000	Innco system	CO3000-4p	N/A	N/A
Antenna Position Tower	MA4640/800-XP-EP	Innco system	N/A	N/A	N/A
Controller	EM1000	Audix	060520	N/A	N/A
Turn Table	N/A	Audix	N/A	N/A	N/A
Loop Antenna	FMZB 1513	Rohde & Schwarz	1513-333	03/17/2024	Biennial
Hybrid Antenna	VULB 9168	Schwarzbeck	760	02/22/2023	Biennial
Horn Antenna	BBHA 9120D	Schwarzbeck	02299	03/24/2024	Biennial
Spectrum Analyzer	FSV40-N	Rohde & Schwarz	102168	07/04/2023	Annual
Signal Analyzer	N9030A	Agilent	MY49431210	01/11/2023	Annual
Attenuator (3 dB)	18B-03	Api tech.	1	01/21/2023	Annual
Attenuator(10 dB)	8493C-10	Agilent	08285	01/21/2023	Annual
Power Amplifier	CBLU1183540	CERNEX	22964	01/21/2023	Annual
Power Amplifier	CBL06185030	CERNEX	22965	01/21/2023	Annual
Power Amplifier	CBL18265035	CERNEX	22966	12/02/2022	Annual
Power Amplifier	CBL26405040	CERNEX	25956	03/11/2023	Annual

Note:

1. Equipment listed above that calibrated during the testing period was set for test after the calibration.
2. Equipment listed above that has a calibration due date during the testing period, the testing is completed before equipment expiration date.
3. Especially, all antenna for measurement is calibrated in accordance with the requirements of C63.5(Version : 2017).

11. ANNEX A_ TEST SETUP PHOTO

Please refer to test setup photo file no. as follows;

No.	Description
1	HCT-RF-2207-FC019-P